SN74AS4374B OCTAL EDGE-TRIGGERED D-TYPE DUAL-RANK FLIP-FLOP WITH 3-STATE OUTPUTS

SDAS109D - APRIL 1989 - REVISED JANUARY 1995

- 3-State Outputs Drive Bus Lines Directly
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic (N) 300-mil DIPs

description

This 8-bit flip-flop features 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. It is particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The eight flip-flops of the SN74AS4374B are edge-triggered D-type flip-flops. On the second positive transition of the clock (CLK) input, the Q outputs are set to the logic levels set up at the data (D) inputs.

(TOP VIEW) 20 1 1D 1Q 19 2D 2Q [2 3Q 🛛 3 18 [] 3D 4Q **∏** 4 17**∏** 4D GND [5 16 V_{CC} 5Q **[**] 6 15 | 5D 6Q **∏** 7 14**∏** 6D 7Q **∏** 8 13**∏** 7D 8Q **1** 9 12 8D OE **1**0 11 CLK

DW OR N PACKAGE

The output-enable (\overline{OE}) input does not affect internal operations of the flip-flops. Previously stored data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN74AS4374B is characterized for operation from 0°C to 70°C.

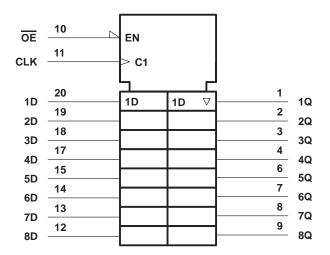
FUNCTION TABLE (each flip-flop)

	INPUTS		OUTPUT
OE	CLK	Dţ	Q
Н	Х	Χ	Z
L	\uparrow	L	L
L	\uparrow	Н	н
L	L	Χ	Q ₀

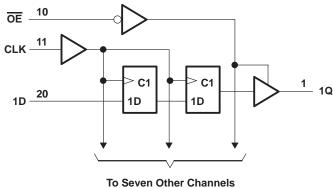
[†] Data presented at the D inputs require two clock cycles to appear at the Q outputs.

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logic symbol†



logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	7 V
Input voltage, V _I	5.5 V
Voltage applied to any output in the high state or power-off state, V _O	5.5 V
Operating free-air temperature range, T _A	0°C to 70°C
Storage temperature range	-65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
V _{IL}	Low-level input voltage			0.8	V
ІОН	High-level output current			-15	mA
loL	Low-level output current			48	mA
TA	Operating free-air temperature	0		70	°C

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		MIN	TYP†	MAX	UNIT
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.5	V
Vari	V _{CC} = 4.5 V	$I_{OH} = -3 \text{ mA}$	2.4	3.2		V
Voн		$I_{OH} = -15 \text{ mA}$	2			
Voi	V _{CC} = 4.5 V	I _{OL} = 32 mA		0.25	0.4	V
VoL		$I_{OL} = 48 \text{ mA}$		0.35	0.5	
I _{OZH}	$V_{CC} = 5.5 V,$	$V_0 = 2.7 \text{ V}$			20	μΑ
lozL	$V_{CC} = 5.5 \text{ V},$	$V_0 = 0.4 V$			-20	μΑ
lį	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1	mA
IH	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20	μΑ
I _{IL}	$V_{CC} = 5.5 \text{ V},$	V _I = 0.5 V			-0.2	mA
I _O ‡	$V_{CC} = 5.5 V,$	V _O = 2.25 V	-30		-112	mA
lcc	$V_{CC} = 5.5 V$,	OE high		100	150	mA

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C.

timing requirements over recommended operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
fclock	Clock frequency	0	125	MHz
t _W	Pulse duration, CLK high or low	4		ns
t _{su}	Setup time, data before CLK↑	4		ns
t _h	Hold time, data after CLK↑	1		ns

switching characteristics (see Figure 1)

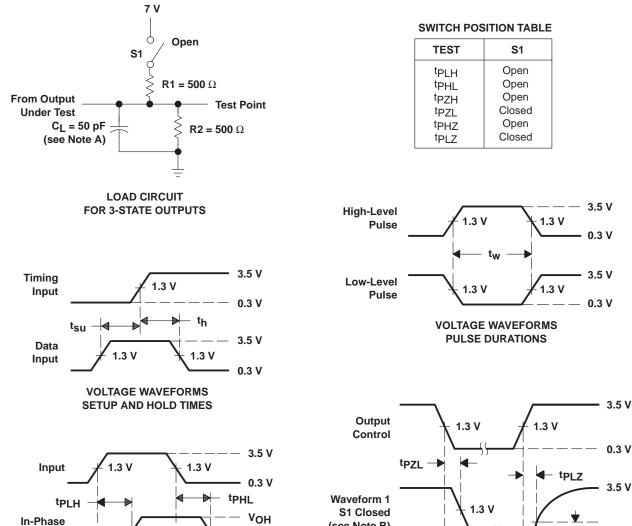
PARAMETER	FROM (INPUT)	TO (OUTPUT)			UNIT
			MIN	MAX]
fmax			125		MHz
t _{PLH}	CLK		2	8	
^t PHL	CLK	Q	2	8	ns
^t PZH			1.5	6	
t _{PZL}	ŌĒ	Q	2.5	8	ns
^t PHZ	ŌĒ	Q	2	6.5	ns
t _{PLZ}			2.5	7	1115

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



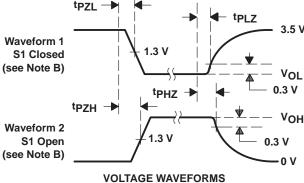
[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, los.

PARAMETER MEASUREMENT INFORMATION



1.3 V 1.3 V Output VOL **tPHL** VOH Out-of-Phase 1.3 V 1.3 V Output VOL

> **VOLTAGE WAVEFORMS PROPAGATION DELAY TIMES**



ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS

NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_f \leq$ 2 ns. $t_f \leq$ 2 ns.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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